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Programa de formação

ITAú analytics.



Módulo I – Fundamentos Computacionais
Sessão 5 - Aula 1 – Teste de Software –
Considerações iniciais
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**ITAú Analytics – Fundamento de Computação – CEDS 111
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Teste de Software

Considerações iniciais

CEDS -111 - Teste de Software - Sessão 5 - Aula 1

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Por que testar software se é caro e demorado?

- Porque **não testar** sai ainda mais caro
- Não testar pode causar desastres e perda de \$\$\$ e até vidas humanas

EXEMPLOS

- Therac-25
- Vôo inaugural do Ariane 5
- Vôo de teste do Airbus 320
- Finanças

Therac-25



EXEMPLOS (2)



ARIANE 5



A-320

<https://youtu.be/I9gELPxPG8Q>

E em Finanças? Crash na Wall Street (1987)?

- **Perda:** \$500 bilhões em um dia!
- **Desastre:** Em 19 de outubro de 1987, o índice Dow Jones caiu 508 pontos, perdendo 22,6% de seu valor total. Esta foi a **maior** perda que Wall Street já sofreu em um único dia
- **Causa:** Um mercado em grande alta foi interrompido por uma série de investigações conduzidas pela SEC e por outras forças do mercado. Como os investidores fugiram de ações investigadas, um número muito grande de ordens de venda foram gerados pelos **software de compra de computadores**, quebrando sistemas e deixando os investidores efetivamente cegos



Teste de Software

- Caixa Preta
- Caixa Branca

Dificuldades do Teste

- Custo
- Tempo para Teste
- Número "alto" de Casos de Teste

Caixa Preta

- Classes de Equivalência
- Valor de Fronteira
- Outros

Caixa Branca

- Control Flow
- Data flow

Como reduzir o número de casos de teste, sem perder a cobertura?

Testar somente os casos estatisticamente mais críticos (perde cobertura)

Usar MATEMÁTICA para reduzir o número de casos de teste

Análise Estatística

- Aplicar **Análise Estatística** para mostrar que **realmente** a técnica em questão (**pairwise testing**, no caso) produz o mesmo resultado que o **Teste Exaustivo** com (muito?) menor número de **casos de teste**

Considerações iniciais

Teoria – Artigo Microsoft

Pairwise Testing in the Real World: Practical Extensions to Test-Case Scenarios

Jacek Czerwotka
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February 2008

Jacek Czerwotka works for Microsoft Corporation in one of its test organizations. For the last few years, he has been involved in the design and implementation of pairwise-related tools, and the evangelization of pairwise testing. You can reach Jacek at jacekcz@microsoft.com

Summary: **Pairwise testing** has become an indispensable tool in a software tester's toolbox. This article pays special attention to **usability of the pairwise-testing technique**. In particular, it focuses on ways in which the pure pairwise-testing approach must be modified to become **practically applicable**, and on the features that tools must offer to support the tester who is trying to use pairwise testing in practice. (15 printed pages)

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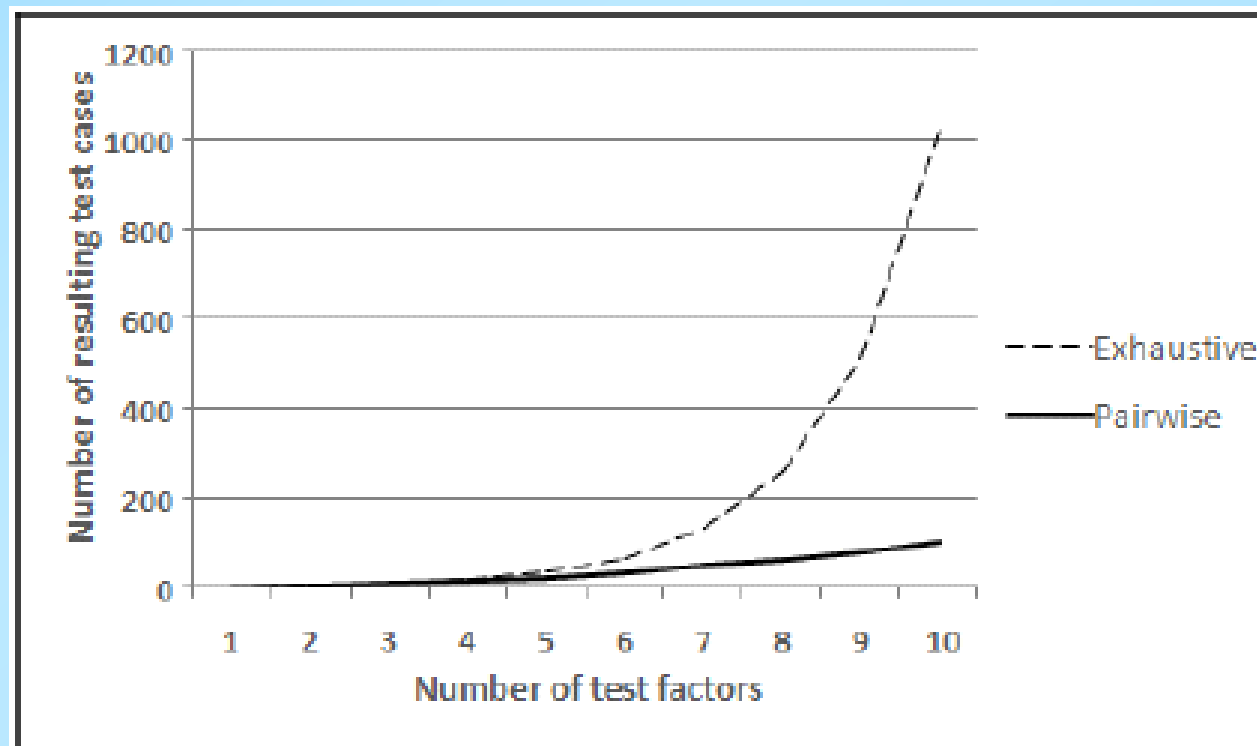
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Overview

Pairwise testing has become an **indispensable** tool in a software tester's toolbox. The technique has been known for almost 20 years [22], but it is only in the last five years that we have seen a tremendous increase in its popularity

So far, information on at least 20 tools that can generate pairwise test cases has been published [1]. Most tools, however, lack practical features that are necessary for them to be used in the industry

A set of possible inputs for any nontrivial piece of software is **too large to be tested exhaustively**. Techniques such as **equivalence partitioning** and **boundary-value analysis** [17] help convert even a large number of test levels into a much smaller set with comparable **defect-detection** power. Still, if software under test (SUT) can be influenced by a number of such factors, exhaustive testing again becomes impractical.



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AETG is a trademark of Telecordia Technologies.

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